


<b>Search Notes</b> 	<b>Application/Control No.</b> 10593781	<b>Applicant(s)/Patent Under Reexamination</b> MAEDE ET AL.
	<b>Examiner</b> Thuy V Tran	<b>Art Unit</b> 2821

SEARCHED			
Class	Subclass	Date	Examiner
315	169.2, 169.3	3/2/08	TT
345	204, 76, 77, 82, 83, 904	3/2/08	TT
324	403, 770, 537	3/2/08	TT

SEARCH NOTES			
Search Notes		Date	Examiner
EAST Text Search (text enclosed)		3/2/08	TT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner